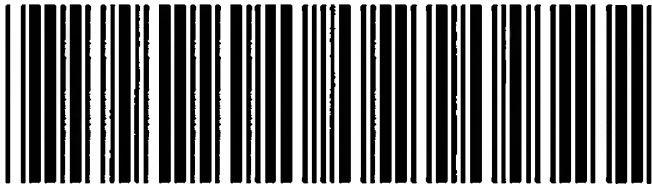


<div>Search Notes</div> <div></div>	<div>Application/Control No.</div> <div>10532827</div>	<div>Applicant(s)/Patent Under Reexamination</div> <div>HASE ET AL.</div>
	<div>Examiner</div> <div>Goff, John L</div>	<div>Art Unit</div> <div>1733</div>

SEARCHED			
Class	Subclass	Date	Examiner
156	247,306.6,308.2,309.6,324	1/5/07	JLG
Above	UPDATED	6/28/07	JLG

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	1/5/07	JLG
Palm Inventor Search	1/5/07	JLG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner